

**PATENT APPLICATION**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Application of:

Docket No: **Q77911**

**Hideya TAKEO et al**

Conf. No.: **3651**

Appln. No.: **10/684,708**

Group Art Unit: **2624**

Filed: **October 15, 2003**

Examiner: **Motsinger, S.**

For: **ABNORMAL PATTERN CANDIDATE DETECTION  
PROCESSING METHOD AND SYSTEM**

**SUBMISSION OF SUBSTITUTE SPECIFICATION**

**MAIL STOP AF**

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

Sir:

This Submission of Substitute Specification (including the specification and Abstract) is to replace the specification of the present application in order to conform with the requirements as set forth in 37 C.F.R. § 1.75(d)(1) and § 608.01(o).

Applicants submit that the substitute Specification (attached hereto) is being filed in response to the Office Action dated June 22, 2007 (to clarify the terms throughout the specification, as requested).

The undersigned respectfully declares that the Substitute Specification submitted herewith does not contain new matter, and thus acceptance is respectfully requested.

Respectfully submitted,

**SUGHRUE MION, PLLC**

Telephone: (202) 293-7060

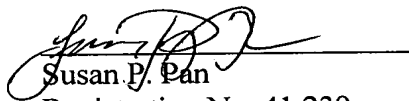
Facsimile: (202) 293-7860

WASHINGTON OFFICE

**23373**

CUSTOMER NUMBER

Date: November 21, 2007

  
Susan P. Pan  
Registration No. 41,239



**CLEAN VERSION OF  
SPECIFICATION**